

BUREAU INTERNATIONAL DES POIDS ET MESURES

**Bilateral Comparison of 1  $\Omega$  Standards**  
**(ongoing BIPM key comparison BIPM.EM-K13.a)**  
**between the NML (Ireland) and the BIPM, April 2006**

by O. Power\*\*, A. Jaouen\*, F. Delahaye \*, N. Fletcher \* and T. J. Witt\*

\*Bureau International des Poids et Mesures, F-92312 Sèvres Cedex

\*\*National Metrology Laboratory, Enterprise Ireland, Glasnevin, Dublin 9, Ireland



November 2006

Pavillon de Breteuil, F-92312 Sèvres Cedex

**Bilateral Comparison of 1  $\Omega$  Standards**  
**(ongoing BIPM key comparison BIPM.EM-K13.a)**  
**between the NML and the BIPM, April 2006**

A comparison of the 1  $\Omega$  reference standards of the BIPM and the National Metrology Laboratory (NML, Dublin, Ireland) was carried out from February to July 2006. Two BIPM 1  $\Omega$  travelling standards, BIV 200 and BIV 205, were shipped to the NML by air courier. Both before and after the measurements at the NML, the standards were measured at the BIPM. All three measurement periods were of approximately one month duration.

The BIPM measurements were carried out by comparison with a 100  $\Omega$  reference resistor whose value is known with respect to the BIPM quantized Hall resistance (QHR) standard. The current in the 1  $\Omega$  resistors during the measurements at the BIPM was 50 mA. The NML carried out measurements of the travelling standards by a substitution method using a current comparator resistance bridge. The NML resistance standard is maintained with respect to  $R_{K-90}$  by means of periodic calibrations and comparisons with the BIPM and by extrapolation of the behaviour over time of its reference group. The measuring current used was also 50 mA.

The reference temperature was 23  $^{\circ}\text{C}$ . The BIPM measurements were carried out at temperatures close to the reference temperature, to within 0.01  $^{\circ}\text{C}$ . Due to an equipment problem at NML, a suitable enclosure at 23  $^{\circ}\text{C}$  was not available, and measurements were carried out at a nominal temperature of 20  $^{\circ}\text{C}$ . Results of all NML and BIPM measurements were corrected to 23  $^{\circ}\text{C}$  using the known temperature coefficients of the travelling standards and the recorded values of ambient temperature. The temperature coefficients of the travelling standard are sufficiently small that the correction from 20 to 23  $^{\circ}\text{C}$  does not significantly increase the uncertainty of the comparison. The pressure coefficients of the travelling standards are negligible.

The reference standards of the two participants are clearly closely correlated, as the NML takes its traceability from the BIPM. The effect of this correlation is reduced by the size of the time lapse since the last comparison of NML's standards with those of the BIPM. This took the form of comparison BIPM.EM-K13.a in April 2004.

Figures 1 and 2 show the measured values obtained (after correction to the reference temperature) for the two standards by the two laboratories. The resistances of the standards

are assumed to vary linearly over time, and linear least-squares fits to the BIPM data for each standard are used to provide the comparison reference. The results of the comparison are presented as the differences between the mean values measured at NML and the values calculated for the same date from the fitted BIPM data. The reference date of the comparison is thus the mean date of the NML measurements, 13 April 2006.

Table 1 lists the results for the comparison and the uncertainty contributions as separate Type A and B components for both laboratories. The following elements are listed:

- (1) the mean resistance value  $R_{\text{NML}}$  of each resistor measured by the NML;
- (2) the Type A uncertainty due to the instability of the resistors and the measuring equipment, computed as the standard uncertainty of the mean value;
- (3) the Type B uncertainty component due to the measuring equipment of the NML. This uncertainty is partially correlated between the different travelling standards used for a comparison and the contributions that are completely or at least partially correlated are indicated by asterisks (\*) in Table 3;
- (4-6) the corresponding quantities for the BIPM; the Type A uncertainty for the resistance value at the reference date is calculated from the least-squares linear fit;
- (7) the difference ( $R_{\text{NML}} - R_{\text{BIPM}}$ ) for each resistor, and (8) the clearly uncorrelated (Type A) part of the uncertainty;
- (9) the result of the comparison, which is the mean of the differences of the calibration results for the two standards;
- (10) the standard uncertainty on this mean difference (including Type A and Type B components from both laboratories).

Table 2 lists the Type B uncertainties associated with maintenance and measuring equipment at the BIPM and Table 3 lists the corresponding uncertainties for the NML.

No key comparison reference value (KCRV) is needed in this bilateral comparison to calculate the degree of equivalence (DoE) between the NML and the BIPM. The two differences (7 above), which allow for the behaviour of each standard individually, are combined as a simple mean (9) to give the DoE given below. The combined uncertainty of the mean difference (10) provides the uncertainty on this DoE. However, in order to link this result to results from other participants in comparison BIPM.EM-K13.a, the KCRV is as usual taken to be the BIPM value.

The measured resistances and differences in table 1 are given with their corresponding absolute standard uncertainties ( $1\sigma$  estimates, in  $\mu\Omega$ ). The final result of the comparison is presented as the degree of equivalence between the NML and the BIPM for values assigned to  $1\Omega$  standards,  $D_{\text{NML}}$ , and its expanded uncertainty,  $U_{\text{NML}}$  ( $k=2$ , 95% confidence level) both expressed in  $10^{-8}$  (i.e. as relative values, where  $1 \times 10^{-8} = 0.01 \mu\Omega$  on a measurement of  $1\Omega$ ):

$$D_{\text{NML}} = (R_{\text{NML}} - R_{\text{BIPM}}) / 1\Omega = 0 \times 10^{-8}$$

$$U_{\text{NML}} = 38 \times 10^{-8}$$

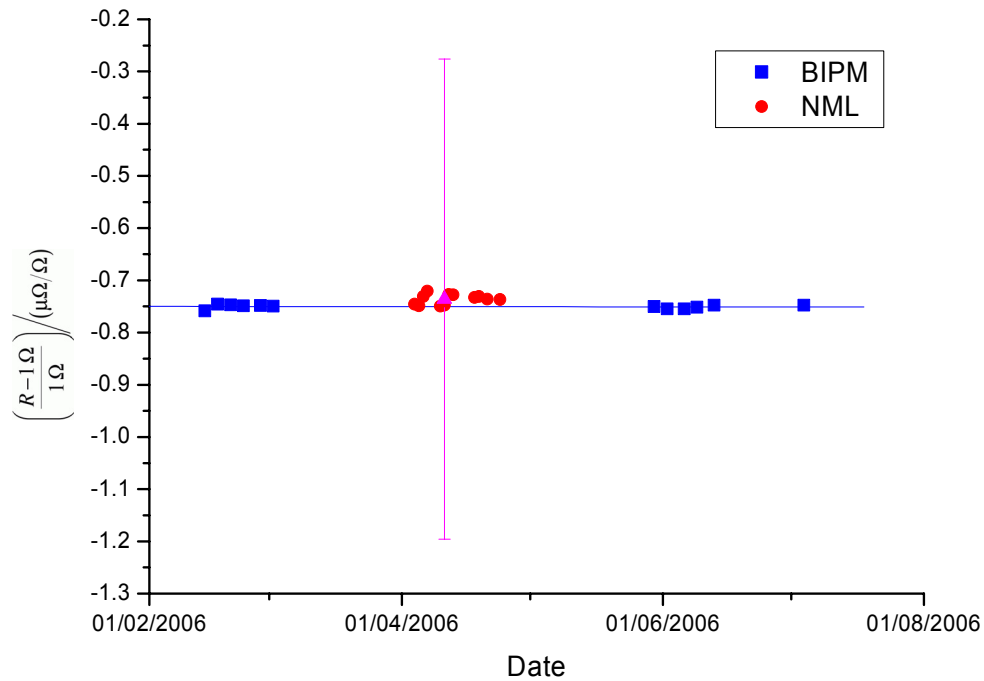
This is a most satisfactory result. The difference between the values assigned to the travelling standards by the two laboratories is less than the expanded uncertainty associated with the difference. The calibration and measurement capability (CMC) of NML held in the BIPM key comparison database appendix C for measurements of  $1\Omega$  standards is  $0.5 \mu\Omega$  (ie  $50 \times 10^{-8}$ ). This comparison result clearly supports this CMC.

#### Comments:

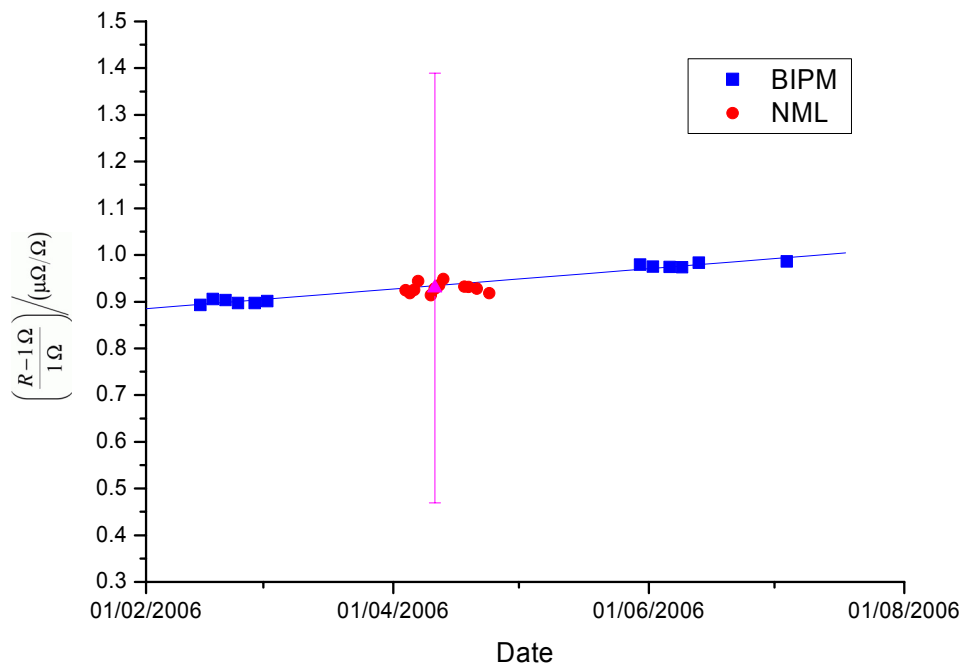
More qualitative information can also be gained from the comparison data, particularly by inspection of figures 1 and 2. Multiple standards and the ‘*A-B-A*’ pattern of measurements are used to reduce the effects of instabilities of the standards on the comparison. From figures 1 and 2, it is clear that, at least at the level of interest defined by the NML uncertainties, the behaviour of the standards is not a limiting factor in this comparison. The linear drift rates obtained for the standards during the period of this comparison have also been compared to the historical data maintained at the BIPM for each standard (covering approximately the last 5 years), and a satisfactory agreement was found.

The consistency of any difference observed for the two standards (i.e. the difference between the differences (7)) can be very revealing. In this case, both differences are not significant given the uncertainties of the NML measurements (even considering only the Type A uncertainties), and no further analysis is necessary.

As a suitable temperature controlled oil bath at  $23^\circ\text{C}$  was not available at the NML at the time of the comparison, the difference in measurement conditions between the two participants was larger than normal for this comparison. However, the travelling standards were well characterised and of very low temperature coefficient so this has not significantly increased the uncertainty of the comparison result. (The correction applied to the NML results to account for the temperature difference is of order  $0.02 \mu\Omega$ .)



**Figure 1:** Relative deviation from the nominal  $1 \Omega$  value of the resistance of BIV200 vs. time: individual measurements of the BIPM and NML, a linear least-squares fit to the BIPM measurements and the reported mean and expanded uncertainty of the NML measurements.



**Figure 2:** as figure 1, but for resistor serial number BIV205

**Table 1.** Results of the NML/BIPM bilateral comparison of 1  $\Omega$  standards using two BIPM travelling standards: mean date 13 April 2006. Uncertainties are 1  $\sigma$  estimates.

		<b>BIV200</b>	<b>BIV205</b>
1	<b>NML</b> $(R - 1 \Omega) / \mu\Omega$	-0.757	+0.941
2	Type A uncertainty / $\mu\Omega$	0.010	0.010
3	Type B uncertainty / $\mu\Omega$	0.23	
4	<b>BIPM</b> $(R - 1 \Omega) / \mu\Omega$	-0.750	+0.936
5	Type A uncertainty / $\mu\Omega$	0.004	0.007
6	Type B uncertainty / $\mu\Omega$	0.016	
7	$(R_{\text{NML}} - R_{\text{BIPM}}) / \mu\Omega$	-0.007	+0.005
8	combined Type A uncertainty / $\mu\Omega$	0.011	0.012
9	Mean difference: $\langle R_{\text{NML}} - R_{\text{BIPM}} \rangle / \mu\Omega$	<b>0.00</b>	
10	Total uncertainty on mean difference / $\mu\Omega$	<b>0.19</b>	

**Table 2.** Estimated Type B standard uncertainties, relative to the nominal value, for 1  $\Omega$  calibrations with the BIPM equipment. A relative uncertainty of  $1 \times 10^{-9}$  corresponds to 0.001  $\mu\Omega$ .

Realization of $R_{\text{H}}(2)$	$2 \times 10^{-9}$
Ratio of resistance of 100 $\Omega$ reference resistor to $R_{\text{H}}(2)$	$3 \times 10^{-9}$
Imprecision in the values of the reference resistors (including uncertainties in extrapolated resistance values and residual power, temperature and pressure effects)	$13 \times 10^{-9}$
Comparison of the travelling standards to the reference resistor (ratio 1 $\Omega$ /100 $\Omega$ )	$9 \times 10^{-9}$
Uncertainty in the temperature correction for the travelling standard	$1 \times 10^{-9}$
<b>rss total</b>	<b><math>16 \times 10^{-9}</math></b>

**Table 3.** Estimated Type B standard uncertainties, relative to the nominal value, for 1  $\Omega$  calibrations with the NML equipment. A relative uncertainty of  $1 \times 10^{-8}$  corresponds to 0.01  $\Omega$ . Asterisks (\*) indicate components that are either completely correlated or probably significantly correlated when measuring different travelling standards.

Calibrated value and drift correction for the 1 $\Omega$ reference standard*	$15 \times 10^{-8}$
Bridge ratio	$17 \times 10^{-8}$
Uncertainty in the temperature correction for the travelling standards (including correction between 20 and 23 $^{\circ}\text{C}$ )	$1 \times 10^{-8}$
<b>rss total</b>	<b><math>23 \times 10^{-8}</math></b>

The following reasoning is applied to the calculation of the uncertainty on the mean difference. For  $n$  measurements of a variable  $x$ ,  $\bar{x} = n^{-1} \sum_{i=1}^n x_i$  and

$$\text{var}(\bar{x}) = n^{-2} \sum_{i=1}^n \text{var}(x_i) = n^{-2} \sum_{i=1}^n \sigma_i^2 = n^{-2} \sum_{i=1}^n [\sigma_A^2(i) + \sigma_B^2(i)] , \quad (1)$$

where  $\sigma_B^2(i)$  is the Type B variance (one that is not evaluated by statistical methods) that is uncorrelated between different  $x_i$  and, for all  $i$ , is equal to  $\sigma_B^2$ . A second Type B variance  $\sigma_{B^*}^2(i)$  is the correlated Type B variance equal to  $\sigma_{B^*}^2$  for all  $i$ . The total variance of the mean difference is the sum of  $\text{var}(\bar{x})$  from (1) and  $\sigma_{B^*}^2$ .